

**LISTE DES PARTICIPANTS/  
LIST OF PARTICIPANTS**

I. ÉTATS MEMBRES/MEMBER STATES

(dans l'ordre alphabétique des noms français des États/  
in alphabetical order of the names in French)

ALLEMAGNE/GERMANY

Armin BARTHEL (Mr.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Justus Sebastian KRUSE (Mr.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office, Munich

Steffen MÜNCH (Mr.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich,

Alessandra SANI (Ms.), Senior Adviser, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Thomas SCHENK (Mr.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Florian SIEBEL (Mr.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Oliver STEINKELLNER (Mr.), Head, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

Veronika TINKL (Ms.), Senior Patent Examiner, Classification Systems Section, German Patent and Trade Mark Office (DPMA), Munich

ARABIE SAOUDITE/SAUDI ARABIA

Mohammed ALTHROWI (Mr.), Head, PCT Department, Saudi Authority for Intellectual Property (SAIP), Riyadh

Abdullzh ALGHAMDI (Mr.), Patents Expert, Saudi Authority for Intellectual Property (SAIP), Riyadh

Mohammed ALMAHZARI (Mr.), Head, Chemistry Department, Patent, Saudi Authority for Intellectual Property (SAIP), Riyadh

Aziz ALMANSOUR (Mr.), Head, Mechanical Patents Department, Patents, Saudi Authority for Intellectual Property (SAIP), Riyadh

AUSTRALIE/AUSTRALIA

Lloyd JAMES (Mr.), Examiner, Patents Examination Group, IP Australia, Canberra

Markus KLAIBER (Mr.), Examiner, Patents Examination Group, IP Australia, Canberra

Deb MCDONNELL (Ms.), Examiner, Patents Examination Group, IP Australia, Melbourne

Alex SIMMONS (Mr.), Patent Examiner, Patents Examination Group, IP Australia, Canberra

MU-EN TIEN (Mr.), Patent Examiner, Patents Examination Group, IP Australia, Canberra

### BRÉSIL/BRAZIL

Catia VALDMAN (Ms.), Head of Telecommunications Division, National Institute of Industrial Property (INPI), Ministry of Economy, Rio de Janeiro

Rodrigo BARBOSA FERRARO (Mr.), Patent Examiner, National Institute of Industrial Property (INPI), Ministry of Economy, Belo Horizonte

Darcio GOMES PEREIRA (Mr.), National Institute of Industrial Property (INPI), Ministry of Economy, Campinas, São Paulo, Brazil

Maria Raquel CATALANO DE SOUSA (Ms.), Patent Examiner, National Institute of Industrial Property (INPI), Ministry of Economy, Rio de Janeiro

Tatielli GONCALVES GREGORIO BARBOSA (Ms.), Patent Examiner, National Institute of Industrial Property (INPI), Ministry of Economy, Rio de Janeiro

### CANADA

Nancy BEAUCHEMIN (Ms.), gestionnaire de programme - International CIB/CPC, Office de la propriété intellectuelle du Canada (CIPO) - Direction des brevets, Innovation, Sciences et Développement économique Canada, Gatineau

### CHINE/CHINA

HU An (Ms.), Director, Division for International Exchanges on Patent Documentation, Patent Documentation Department, Patent Office, China National Intellectual Property Administration (CNIPA), Beijing

CAO Xiaoxing (Mr.), Examiner, Patent Examination Cooperation Guangdong Center, Patent Office, China National Intellectual Property Administration (CNIPA), Guangzhou

DONG Yan (Ms.), Project Administrator, Division for International Exchanges on Patent Documentation, Patent Documentation Department, Patent Office, China National Intellectual Property Administration (CNIPA), Beijing

LI Rong (Ms.), Director, Research Section, Research and Development Department, China Patent Technology Development Corporation, China National Intellectual Property Administration (CNIPA), Beijing

NING Linjian (Ms.), Director, Section II, Department IV, China Patent Technology Development Corporation, China National Intellectual Property Administration (CNIPA), Beijing

TONG Jingyi (Ms.), Examiner, Patent Examination Administration Department, Patent Examination Cooperation Beijing Center, Patent Office, China National Intellectual Property Administration (CNIPA), Beijing

WU Jian (Mr.), Senior IP Expert, Patent Examination Cooperation Guangdong Center, Patent Office, China National Intellectual Property Administration (CNIPA), Guangzhou

#### ESPAGNE/SPAIN

ELENA PINA (Sra.), Técnica Superior Examinadora de Patentes, División de física y de patentes eléctricas, Oficina Española de Patentes y Marcas, Ministerio de Industria, Comercio y Turismo (OEPM), Madrid

#### ESTONIE/ESTONIA

Tiina LILLEPOOL (Ms.), Principal Examiner, The Estonian Patent Office, Tallinn

#### ÉTATS-UNIS D'AMÉRIQUE/UNITED STATES OF AMERICA

William BREWSTER (Mr.), Supervisor Patent Classifying, CSD, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

Matthew BROOKS (Mr.), Supervisory Patent Classifier - Mechanical, Classification Standards and Development, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

Yen NGUYEN (Ms.), Supervisory Patent Classifier - Chemical, Classification Standards and Development [CSD], United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

Jill GRAY (Ms.), Patent Classifier - Chemical, Classification Standards and Development, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

David HOMZA (Mr.), Director, Classification Standards and Development, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

Chris JETTON (Mr.), Mechanics Classifier, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

Gustavo LOPEZ (Mr.), Patent Classifier - Electrical, Classification Standards and Development, United States Patent and Trademark Office (USPTO), Department of Commerce, Alexandria

#### FÉDÉRATION DE RUSSIE/RUSSIAN FEDERATION

Zoya VOYTSEKHOVSKAYA (Ms.), Senior Researcher, Federal Service for Intellectual Property (ROSPATENT), Moscow

Fedor SARATOWSKIY (Mr.), Researcher, Federal Service for Intellectual Property (ROSPATENT), Moscow

## FRANCE

Magalie MATHON (Mme), examinatrice en charge de la CIB, Département des brevets, Institut national de la propriété industrielle (INPI), Courbevoie

David DURIEZ (M.), expert en chimie, Département des brevets, Institut national de la propriété industrielle (INPI), Courbevoie

Géraldine VENTORUZZO (Mme), expert en électricité, Direction des brevets, Institut national de la propriété industrielle (INPI), Courbevoie

Carole BREMEERSCH (Mme), conseillère, Propriété intellectuelle, Économie et développement, Mission permanente, Genève

Josette HERESON (Mme), Conseillère diplomatique, Mission permanente, Genève

## IRLANDE/IRELAND

Fergal BRADY (Mr.), Examiner of Patents, Patent Examination, Intellectual Property Office of Ireland, Kilkenny

## ISRAËL/ISRAEL

Orit REGEV (Ms.), Deputy Superintendent of Examiners, Patent Office, Ministry of Justice, Jerusalem

## JAPON/JAPAN

Sumio MIGITA (Mr.), Deputy Director, Examination Policy Planning Office, Japan Patent Office (JPO), Ministry of Economy, Trade and Industry, Tokyo

Kotaro FUJISHIMA (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Ministry of Economy, Trade and Industry, Tokyo

Masaya FUJIWAKI (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Ministry of Economy, Trade and Industry, Tokyo

Shota HOSOKAWA (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Ministry of Economy, Trade and Industry, Tokyo

Michiru MIURA (Ms.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Ministry of Economy, Trade and Industry, Tokyo

Tatsuhiko NISHIZAWA (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Ministry of Economy, Trade and Industry, Tokyo

Yuto NISHIZUKA (Mr.), Assistant Director, Examination Policy Planning Office, Japan Patent Office (JPO), Ministry of Economy, Trade and Industry, Tokyo

Yusuke OKATANI (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Ministry of Economy, Trade and Industry, Tokyo

Masuji YAMADA (Mr.), Classification Project Coordinator, Examination Policy Planning Office, Japan Patent Office (JPO), Ministry of Economy, Trade and Industry, Tokyo

#### MEXIQUE/MEXICO

Yari FERNANDEZ SANTA CRUZ RUIZ (Sra.), Especialista en Propiedad Industrial, Instituto Mexicano de la Propiedad Industrial (IMPI), México

Hosanna MORA GONZÁLEZ (Sra.), Especialista en Propiedad Industrial, Instituto Mexicano de la Propiedad Industrial (IMPI), México

Pablo ZENTENO MARQUEZ (Sr.), Especialista en Propiedad Industrial, Instituto Mexicano de la Propiedad Industrial (IMPI), México

#### NORVÈGE/NORWAY

Bjørn TISTHAMMER (Mr.), Senior Examiner, Norwegian Industrial Property Office (NIPO), Oslo

Bente AARUM-ULVÅS (Ms.), Senior Examiner, Norwegian Industrial Property Office (NIPO), Oslo

#### OUZBÉKISTAN/UZBEKISTAN

Ikram ABDUKADIROV (Mr.), Head Invention and Utility Models Department, Intellectual Property Agency under the Ministry of Justice of the Republic of Uzbekistan, Tashkent

Aysuliu POLATOVA (Ms.), Patent Examiner, Department of Inventions and Utility Models, Intellectual Property Agency under the Ministry of Justice of the Republic of Uzbekistan, Tashkent

Nilufar RAKHMATULLAEVA (Ms.), Top Examiner, Department of Inventions and Utility Models, Intellectual Property Agency under the Ministry of Justice of the Republic of Uzbekistan, Tashkent

#### POLOGNE/POLAND

Małgorzata KOZŁOWSKA (Ms.), Expert Coordinator, Patent Office of the Republic of Poland, Warsaw

#### RÉPUBLIQUE DE CORÉE/REPUBLIC OF KOREA

CHA HyunSoo (Mr.), Associated Staff, Korean Intellectual Property Office (KIPO), Daejeon

HAN Donghee, Patent Information Promotion Center (PIPC), Daejeon

LEE Jaeheon (Mr.), Patent Information Promotion Center (PIPC), Daejeon

LEE Wangseok (Mr.), Head of Group, Korean Intellectual Property Office (KIPO), Daejeon

PARK Hyunchul (Mr.), Patent Information Promotion Center (PIPC), Daejeon

SONG Wongyu (Mr.), Deputy Director, Patent System Administration Division, Korean Intellectual Property Office (KIPO), Daejeon

JEONG Jieun (Ms.), Patent Information Promotion Center (PIPC), Daejeon

PARK Si Young (Mr.), Counsellor, Permanent Mission, Geneva

#### RÉPUBLIQUE TCHÈQUE/CZECH REPUBLIC

Jarmila AVRATOVA (Ms.), Engineer, Patent Information, Industrial Property Office of the Czech Republic, Prague

#### ROYAUME-UNI/UNITED KINGDOM

Jeremy COWEN (Mr.), Senior Patent Examiner - Classification, Patent Examining Division, UK Intellectual Property Office (UK IPO), Newport

Huw THOMAS (Mr.), Senior Patent Examiner, Patent Examining Division, UK Intellectual Property Office (UK IPO), Newport

Rhys WILLIAMS (Mr.), Senior Patent Examiner, Patent Examining Division, UK Intellectual Property Office (UK IPO), Newport

Patrick PURCELL (Mr.), Examiner, Patent Examining Division, UK Intellectual Property Office (UK IPO), Newport

#### SLOVAQUIE/SLOVAKIA

Lukrécia MARČOKOVÁ (Ms.), Director, Patent Department, Industrial Property Office of the Slovak Republic, Banská Bystrica

#### SLOVÉNIE/SLOVENIA

Barbara REŽUN (Ms.), Attaché, Permanent Mission, Geneva

#### SUÈDE/SWEDEN

Anders BRUUN (Mr.), Patent Expert, Swedish Intellectual Property Office (PRV), Stockholm

Moa EMLING (Ms.), Senior Patent Examiner, Chemistry Department, Swedish Intellectual Property Office (PRV), Stockholm

Tomas LUND (Mr.), Senior Patent Examiner, Swedish Intellectual Property Office (PRV), Stockholm

## SUISSE/SWITZERLAND

Pascal WEIBEL (M.), Chef Examen, Division des brevets, Institut fédéral de la propriété intellectuelle (IPI), Berne

Philippe TATASCIORE (M.), Expert en brevet, Division des brevets, Institut fédéral de la propriété intellectuelle (IPI), Berne

Michael STALDER (M.), Expert en brevet, Division des brevets, Institut fédéral de la propriété intellectuelle (IPI), Berne

## UKRAINE

Volodymyr FESHCHENKO (Mr.), Deputy of Director General, Ministry of Economy of Ukraine, State Enterprise «Ukrainian Intellectual Property Institute» Ukrpatent, Kyiv

Oksana PARKHETA (Ms.), Deputy Head of Department, Department of the Information Support, Ministry of Economy of Ukraine, State Enterprise «Ukrainian Intellectual Property Institute» (Ukrpatent), Kyiv

Sergii TORIANIK (Mr.), Director of Department, Department for Examination of Applications for Inventions, Utility Models and Layout Designs, Ministry of Economy of Ukraine, State Enterprise «Ukrainian Intellectual Property Institute» (Ukrpatent), Kyiv

Svitlana ZHAIVORONOK (Ms.), Professional in Intellectual Property 1 category, Department of Patent Information, Documentation and Standardization, Ministry of Economy of Ukraine, State Enterprise «Ukrainian Intellectual Property Institute» (Ukrpatent), Kyiv

## **II. ÉTATS OBSERVATEURS/OBSERVER STATES**

### HONGRIE/HUNGARY

Ildiko DIOSPATONYI (Ms.), Patent Examiner, Pharmaceuticals and Agriculture Section, Hungarian Intellectual Property Office (HIPO), Budapest

Zsuzsanna TOROCSIK (Ms.), Patent Examiner, Chemistry and Biotechnology Section, Hungarian Intellectual Property Office (HIPO), Budapest

### INDE/INDIA

Atiqullah MD (Mr.), Assistant Controller, Patents and Designs, Department for Promotion of Industry and Internal Trade (DPIIT), Ministry of Commerce and Industry, New Delhi

Suchetana BHATTACHARYYA (Ms.), Examiner, Patents and Designs, Department for Promotion of Industry and Internal Trade (DPIIT), Ministry of Commerce and Industry, New Delhi

SINGAPOUR/SINGAPORE

Yu LIU (Ms.), Principal Patent Examiner, Patent Search, Examination & Analytics, Intellectual Property Office of Singapore, Singapore

Happy TAN (Mr.), Senior Patent Examiner, Patent Search, Examination & Analytics, Intellectual Property Office of Singapore, Singapore

VIET NAM

BUI Duy Nghia (Mr.), Deputy Director, IP Information Center, IP Viet Nam, Ha Noi

LE Ngoc Lam (Mr.), Counsellor, Permanent Mission, Geneva

**III. ORGANISATIONS INTERNATIONALES INTERGOUVERNEMENTALES/  
INTERNATIONAL INTERGOVERNMENTAL ORGANIZATIONS**

ORGANISATION EURASIENNE DES BREVETS (OEAB)/EURASIAN PATENT  
ORGANIZATION (EAPO)

Andrey GOLUBEV (Mr.), Principal Examiner, Chemistry and Medicine Division, Examination Department, Moscow

Dmitriy GUDILIN (Mr.), Principal Examiner, Mechanics, Physics and Electrical Engineering Division, Examination Department, Moscow

Valeriy MALAY (Mr.), Principal Examiner, Mechanics, Physics and Electrical Engineering Division, Examination Department, Moscow

ORGANISATION EUROPÉENNE DES BREVETS (OEB)/EUROPEAN PATENT  
ORGANISATION (EPO)

Roberto IASEVOLI (Mr.), Head, Classification Board, Rijswijk

Thierry BEC (Mr.), Classification Board, Munich

Massimo CRESCENTI (Mr.), Classification Board, Rijswijk

Agnès GAMEZ MERLE (Ms.), Classification Board, Rijswijk

Joannes MARTINEZ VALERO (Mr.), Classification Board, Rijswijk

Ciro PERNICE (Mr.), Classification Board, Rijswijk

John RENGGLI (Mr.), Classification Board, Munich

Peter SWARÉN (Mr.), Classification Board, Rijswijk

Norbert WIENOLD (Mr.), Classification Board, Munich



#### **IV. BUREAU/OFFICERS**

président/Chair: Oliver STEINKELLNER (M./Mr.) (ALLEMAGNE/GERMANY)

vice-président/  
Vice Chair Pascal WEIBEL (M./Mr.) (SUISSE/SWITZERLAND)

secrétaire/Secretary: XU Ning (Mme/Ms.) (OMPI/WIPO)

#### **V. BUREAU INTERNATIONAL DE L'ORGANISATION MONDIALE DE LA PROPRIÉTÉ INTELLECTUELLE (OMPI)/ INTERNATIONAL BUREAU OF THE WORLD INTELLECTUAL PROPERTY ORGANIZATION (WIPO)**

Ken-Ichiro NATSUME (M./Mr.), sous-directeur général du Secteur de de l'infrastructure et des plateformes/Assistant Director General, Infrastructure and Platforms Sector

Kunihiko FUSHIMI (M./Mr.), directeur de la Division des classifications internationales et des normes, Secteur de de l'infrastructure et des plateformes/Director, International Classifications and Standards Division, Infrastructure and Platforms Sector

Patrick FIÉVET (M./Mr.), chef de la Section des systèmes informatiques, Division des classifications internationales et des normes, Secteur de de l'infrastructure et des plateformes /Head, IT Systems Section, International Classifications and Standards Division, Infrastructure and Platforms Sector

XU Ning (Mme/Ms.), chef de la Section de la classification internationale des brevets (CIB), Division des classifications internationales et des normes, Secteur de de l'infrastructure et des plateformes/Head, International Patent Classification (IPC) Section, International Classifications and Standards Division, Infrastructure and Platforms Sector

Rastislav MARČOK (M./Mr.), administrateur principal de la classification des brevets de la Section de la classification internationale des brevets (CIB), Division des classifications internationales et des normes, Secteur de de l'infrastructure et des plateformes/Senior Patent Classification Officer, International Patent Classification (IPC) Section, International Classifications and Standards Division, Infrastructure and Platforms Sector

Isabelle MALANGA SALAZAR (Mme/Ms.), assistante à l'information de la Section de la classification internationale des brevets (CIB), Division des classifications internationales et des normes, Secteur de de l'infrastructure et des plateformes/Information Assistant, International Patent Classification (IPC) Section, International Classifications and Standards Division, Infrastructure and Platforms Sector

[يلي ذلك المرفق الثاني]